Application/Control No. Applicant(s)/Patent Under Reexamination 09/147,320 LEIJON ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Chau N. Nguyen 2831 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 02-1986 Α US-4,571,453 Takaoka et al. 174/110A В US-C US-D US-Ε US-F US-US-G US-Н US-J US-Κ US-L US-US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q

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